Form PTO 1449 (Modified)	U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE			ATTY DOCKET NO. 242838US8CONT		SERIAL NO. NEW APPLICATION		
			APPLICANT					
LIST OF REFERENCES CITED BY APPLICANT				Hiroyuki MATSUURA, et al.				
				FILING DATE		GROUP		
				HEREWITH				
U.S. PATENT DOCUMENTS								
EXAMINER		DOCUMENT	DATE	NAME	TOLASS	SUB	FILING DAT	E
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		DOCUMENT NUMBER	DATE	COUNTRY		TRANSLATION YES NO		
n	AO	2001-83041	03-30-2001	JAPAN (W/ ENGLISH ABSTRACT)			Х	
	AP	2001-41915	02-16-2001	JAPAN (W/ ENGLISH ABSTRACT)			X	
	AQ	5-232328	09-10-1993	JAPAN (W/ ENGLISH ABSTRACT)			х	
	AR	8-278221	10-22-1996	JAPAN (W/ ENGLISH ABSTRACT)			Х	
	AS	6-307983	11-04-1994	JAPAN (W/ ENGLISH ABSTRACT)			Х	
	AT	8-201223	08-09-1996	JAPAN (W/ ENGLISH ABSTRACT)			X	
Tu	AU	63-43108	02-24-1988	JAPAN (W/ENGLISH ABSTRACT)			х	
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OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)								
	AW							
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Examiner	·	D			Date Co	nsidered	8/31/03	
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*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.								

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